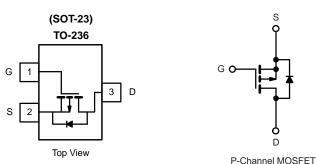


RSM3407-VB Datasheet

P-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY							
V _{DS} (V)	R _{DS(on)} (Ω) Typ.	I _D (A) ^a	Q _g (Typ.)				
	0.046 at V _{GS} = - 10 V	- 5.6					
- 30	0.049 at V _{GS} = - 6 V	- 5	11.4 nC				
	0.054 at V _{GS} = - 4.5 V	-4.5					



FEATURES

- TrenchFET[®] Power MOSFET
- 100 % R_g Tested

APPLICATIONS

- For Mobile Computing
 - Load Switch
 - Notebook Adaptor Switch
 - DC/DC Converter



Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	- 30	V	
Gate-Source Voltage		V _{GS}	± 20		
	T _C = 25 °C		- 5.6		
Continuous Drain Current (T. 150 °C)	T _C = 70 °C		- 5.1		
Continuous Drain Current ($T_J = 150 \ ^{\circ}C$)	T _A = 25 °C	I _D	- 5.4 ^{b,c}		
	T _A = 70 °C		- 4.3 ^{b,c}	A	
Pulsed Drain Current (t = 100 µs)		I _{DM}	- 18		
Continous Source-Drain Diode Current	T _C = 25 °C	1	- 2.1		
Continous Source-Drain Diode Current	T _A = 25 °C	I _S	- 1 ^{b,c}		
	T _C = 25 °C		2.5		
Movimum Dower Discipation	T _C = 70 °C		1.6	w	
Maximum Power Dissipation	T _A = 25 °C	P _D	1.25 ^{b,c}	vv	
	T _A = 70 °C		0.8 ^{b,c}		
Operating Junction and Storage Temperatur	T _J , T _{stg}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS

Parameter			Maximum	Unit				
$t \le 5 s$	R _{thJA}	75	100	°C/W				
Steady State	R _{thJF}	40	50					
		Stoody Stoto R	$t \le 5 s$ R_{thJA} 75	t \leq 5 s R _{thJA} 75 100				

Notes:

a. Based on T_C = 25 °C.

b. Surface mounted on 1" x 1" FR4 board.

c. t = 5 s.

d. Maximum under steady state conditions is 166 °C/W.

SM3407				C	B.	VBse	
					www.VI	3semi.c	
SPECIFICATIONS (T _J = 25 °C			B.G.:n	True	Max	Unit	
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static			1	1	1	1	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 V, I_D = -250 \mu A$	- 30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA		- 19		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	iβ = - 230 μA		4		mv/ C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = -250 \ \mu A$	- 0.5		- 2.0	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
	I _{DSS}	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$			- 1		
Zero Gate Voltage Drain Current		$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$			- 5	μA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le$ - 5 V, V_{GS} = - 10 V	- 2.5			А	
		$V_{GS} = -10 \text{ V}, \text{ I}_{D} = -4.4 \text{ A}$		0.046			
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} =- 6 V, I _D = - 4 A		0.049		Ω	
		$V_{GS} = -4.5 \text{ V}, \text{ I}_{D} = -3.6 \text{ A}$		0.054			
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 15 V, I _D = - 3.4 A		18		S	
Dynamic ^b			4				
Input Capacitance	C _{iss}			1295			
Output Capacitance	C _{oss}	V_{DS} = - 15 V, V_{GS} = 0 V, f = 1 MHz		150		pF	
Reverse Transfer Capacitance	Cros			130			

Dynamic ^b						
Input Capacitance	C _{iss}			1295		
Output Capacitance	C _{oss}	V _{DS} = - 15 V, V _{GS} = 0 V, f = 1 MHz		150		pF
Reverse Transfer Capacitance	C _{rss}	C _{rss}		130		
Total Gate Charge	Q _g V	$V_{DS} = -15$ V, $V_{GS} = -10$ V, $I_{D} = -5.4$ A		24	36	
				11.4	17	nC
Gate-Source Charge	Q_{gs} V_{DS} = - 15 V, V_{GS} = - 4.5 V, I_D = - 5.4 A			3.4		
Gate-Drain Charge	Q _{gd}			3.8		
Gate Resistance	Rg	f = 1 MHz	1.5	7.7	15.4	Ω
Turn-On Delay Time	t _{d(on)}			13	20	
Rise Time	t _r	V_{DD} = - 15 V, R_L = 3.5 Ω		4	8	
Turn-Off Delay Time	t _{d(off)}	$I_{D}\cong$ - 4.3 A, V_{GEN} = - 10 V, R_{g} = 1 Ω		38	57	nc
Fall Time	t _f			6	12	
Turn-On Delay Time	t _{d(on)}			28	42	ns
Rise Time	t _r	V_{DD} = - 15 V, R_L = 3.5 Ω		16	24	
Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D}\cong$ - 4.3 A, V_GEN = - 4.5 V, R_g = 1 Ω		30	45	
Fall Time	t _f	7		10	20	
Drain-Source Body Diode Characteristic	s					
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			- 2.1	А
Pulse Diode Forward Current (t = 100μ s)	I _{SM}				- 80	~
Body Diode Voltage	V_{SD}	$I_{S} = -4.3 \text{ A}, V_{GS} = 0 \text{ V}$		- 0.8	- 1.2	V
Body Diode Reverse Recovery Time	t _{rr}			15	23	ns
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = - 4.3 A, dl/dt = 100 A/µs, T ₁ = 25 °C		7	14	nC
Reverse Recovery Fall Time	t _a	-1F = -4.3 A, and = 100 A/		8		20
Reverse Recovery Rise Time	t _b]		7		ns

Notes:

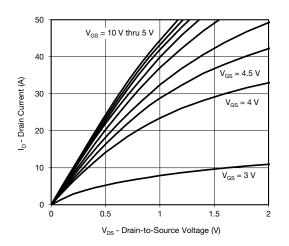
a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

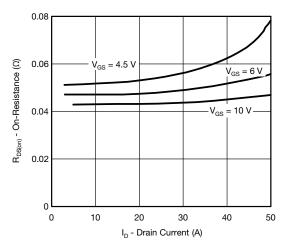
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



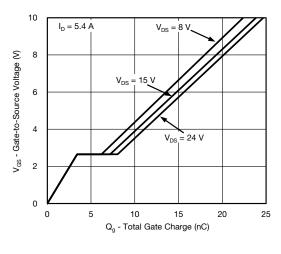




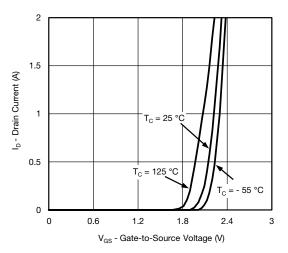
Output Characteristics



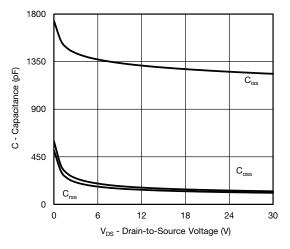
On-Resistance vs. Drain Current



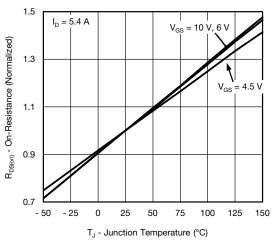
Gate Charge



Transfer Characteristics

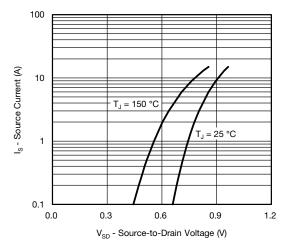






On-Resistance vs. Junction Temperature



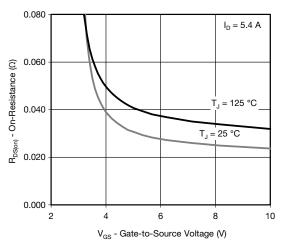


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

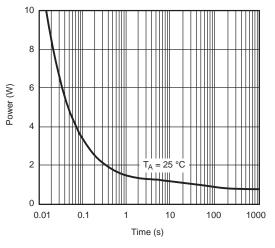




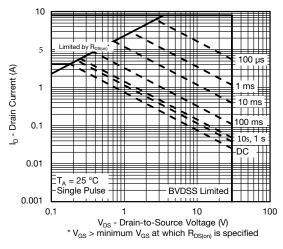
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage



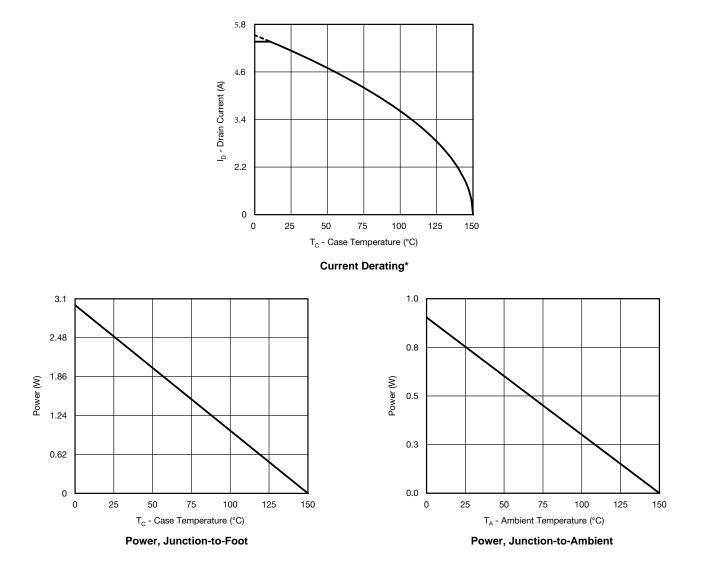
Single Pulse Power (Junction-to-Ambient)



Safe Operating Area, Junction-to-Ambient



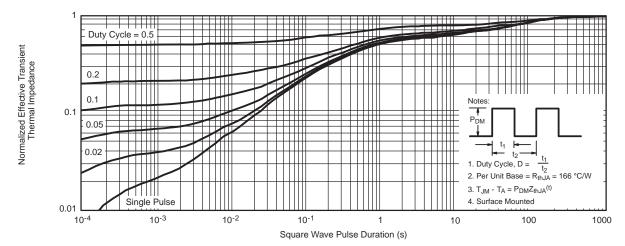
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



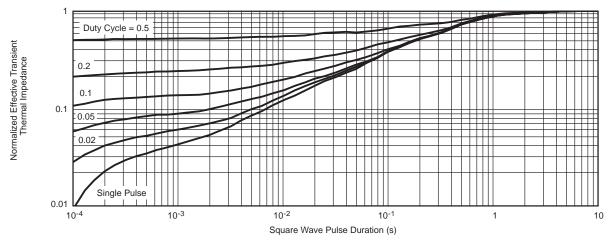
* The power dissipation P_D is based on $T_{J(max.)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



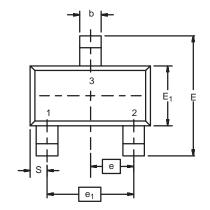
Normalized Thermal Transient Impedance, Junction-to-Ambient

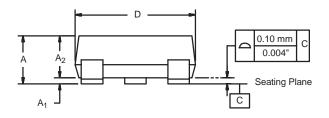


Normalized Thermal Transient Impedance, Junction-to-Foot



SOT-23 (TO-236): 3-LEAD



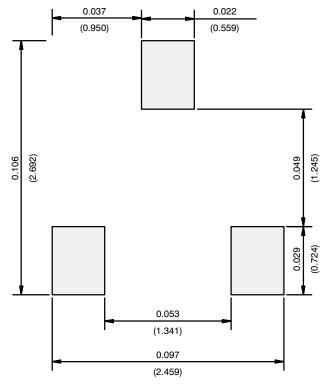




Dim A A ₁	Min 0.89	Max	Min	Мах	
	0.80			max	
Δ.	0.03	1.12	0.035	0.044	
~1	0.01	0.10	0.0004	0.004	
A ₂	0.88	1.02	0.0346	0.040	
b	0.35	0.50	0.014	0.020	
с	0.085	0.18	0.003	0.007	
D	2.80	3.04	0.110	0.120	
E	2.10	2.64	0.083	0.104	
E ₁	1.20	1.40	0.047	0.055	
е	0.95 BSC		0.0374 Ref		
e ₁	1.90 BSC		0.0748 Ref		
L	0.40	0.60	0.016	0.024	
L ₁	0.64	Ref	0.025 Ref		
S	0.50 Ref		0.020 Ref		
q	3°	8°	3°	8°	



RECOMMENDED MINIMUM PADS FOR SOT-23



Recommended Minimum Pads Dimensions in Inches/(mm)



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